Electron Diffraction Data in the CSD



advancing structural science

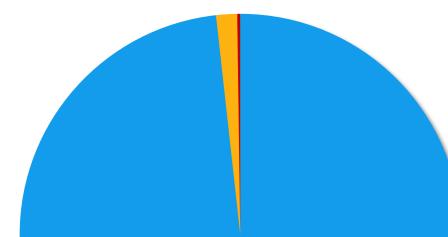
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Email: njohnson@ccdc.cam.ac.uk Website: www.ccdc.cam.ac.uk Twitter: ccdc_cambridge Facebook: ccdc.cambridge YouTube: CCDCCambridge

The CSD

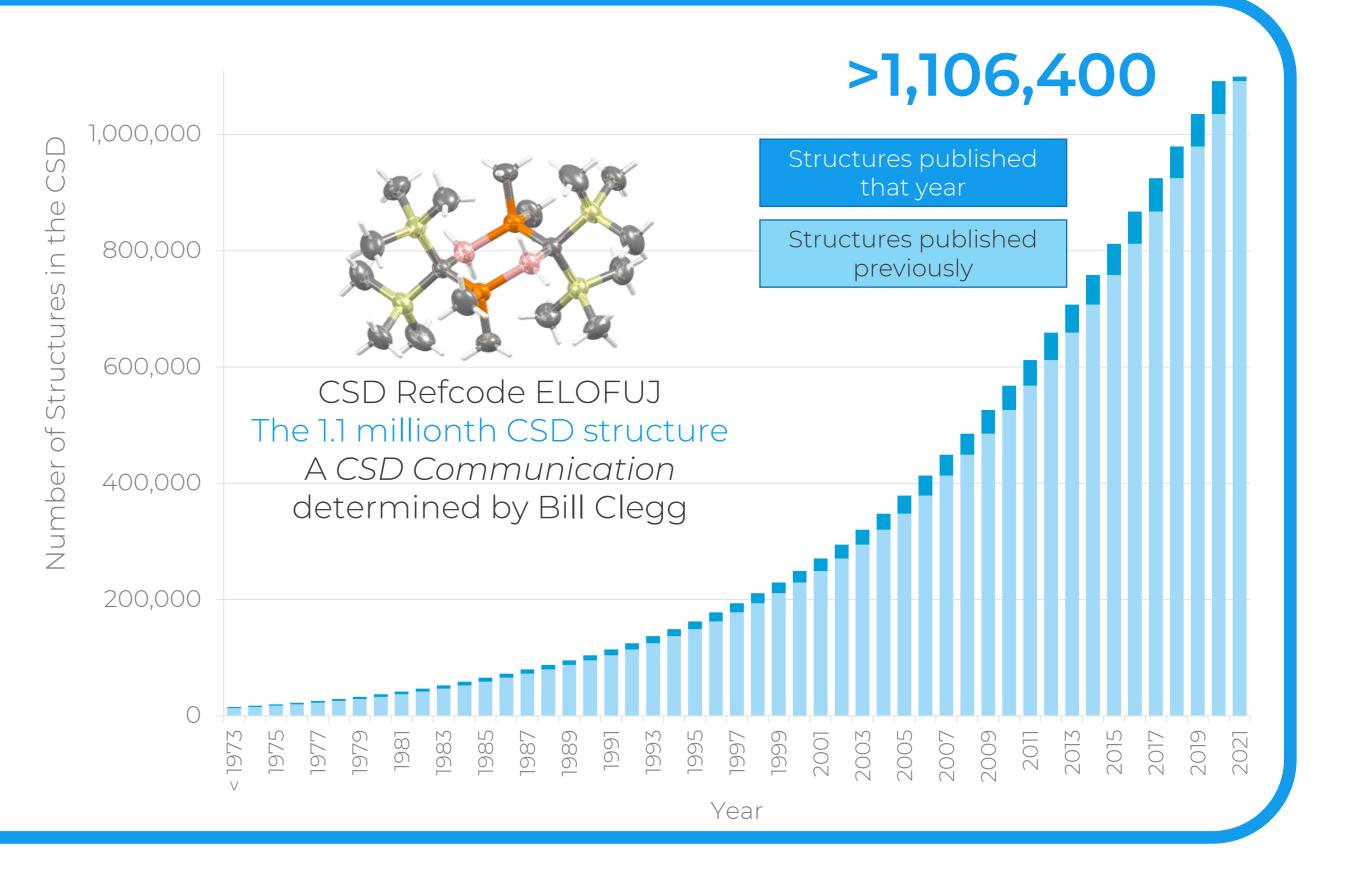
The Cambridge Structural Database (CSD) is a curated database of over 1.1 million small molecule organic and metal-organic experimental crystal structures. Data is curated in house, validated and stored in a standardised format so that the structures are searchable, reusable and easily findable.

Data in the CSD



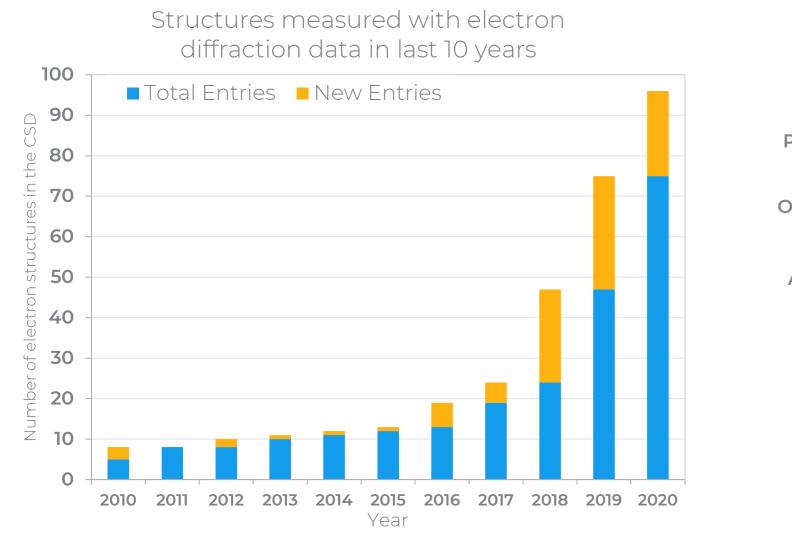
Alongside curating new structures, each year existing entries are enhanced with additional information or to improve the consistency of data and the searchability for users.

Data in the CSD is predominantly from small molecule single crystal experiments. As such, one focus for our CSD Improvement projects is the identification and labelling of nonroutine experimental techniques. These investigations have mainly concentrated on synchrotron and neutron data, but we have recently turned our attention to the small but growing number of electron diffraction datasets.

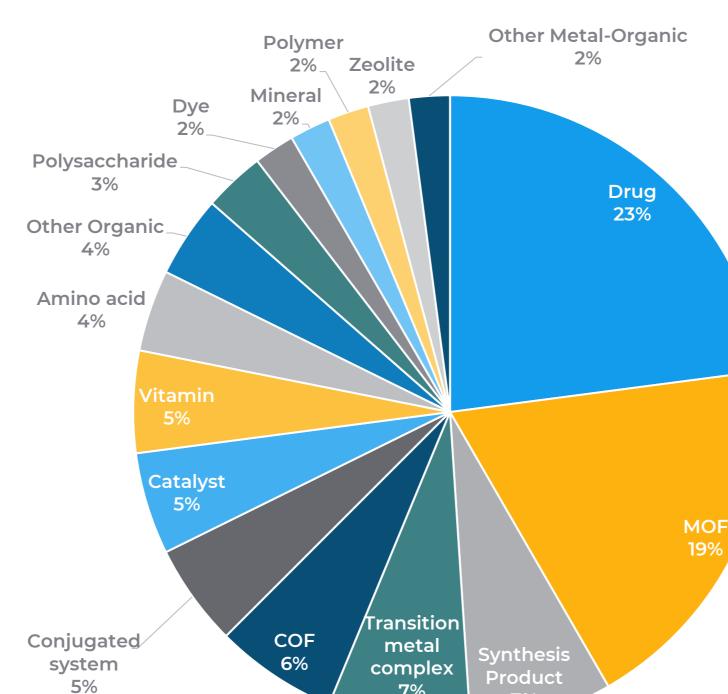


■ Lab X-ray ■ Synchrotron ■ Neutron ■ Electron

Electron Diffraction Data

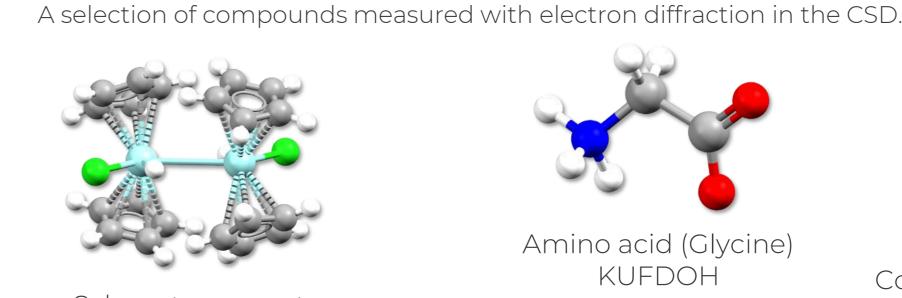


97 unique electron diffraction datasets have been identified in the CSD (v5.42 February update) with a wide variety of different 5% compounds studied. The technique has had renewed interest due to developments in collection and data data automated processing.¹

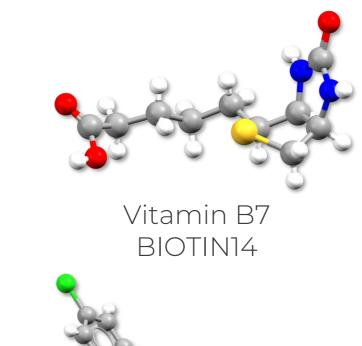


Classification of electron diffraction structures

in the CSD

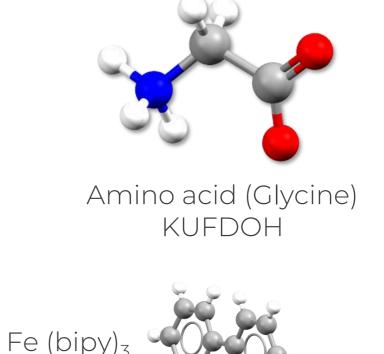


Schwartz reagent DIZZUK



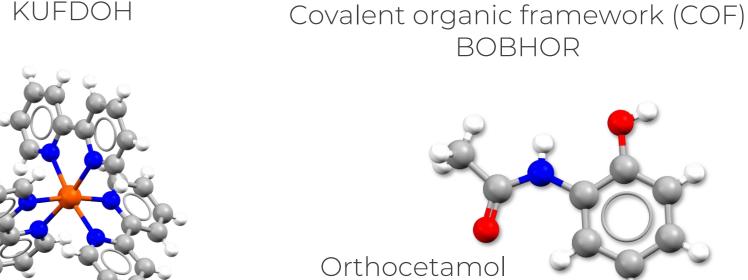
Loratadine (BEQGIN08)

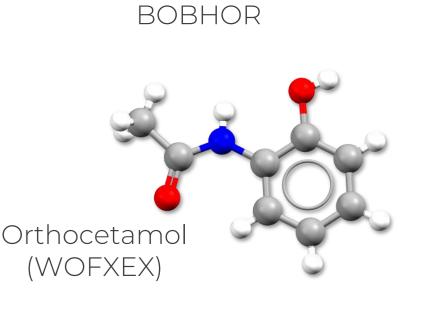
Anti-allergy medication

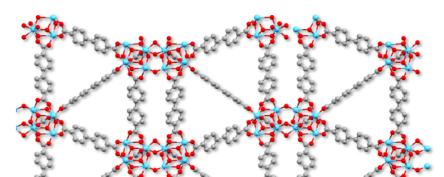


Zeolite

IKUDOJ





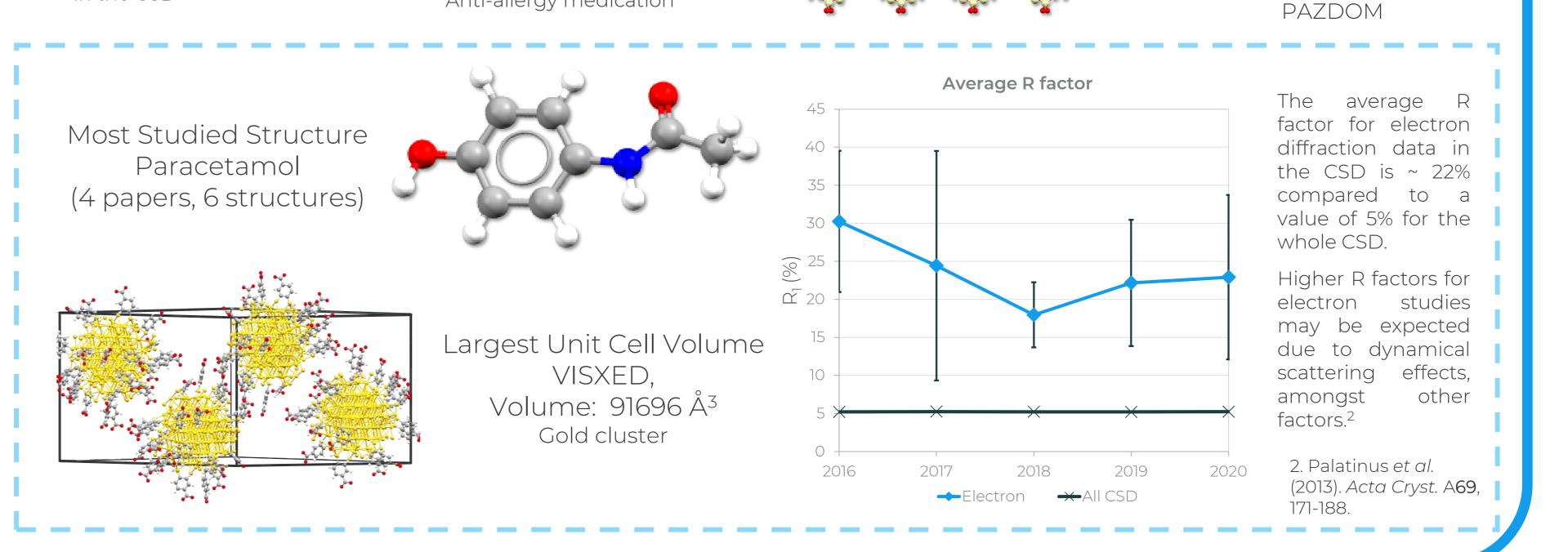


Nanoscale MOF

Structures with Raw Data DOIs

CCDC does not store raw diffraction data. However, a DOI for the raw data, stored in another repository, can be linked to the entry. This 'Raw Data DOI' can be provided during deposition to CCDC or in 'My Structures'.

Currently, 56 structures in the CSD (0.005%) have an associated raw data DOI. Interestingly, 14% of electron diffraction structures have a raw data DOI associated with them.



NUXKO

. Gemmi et al. (2019). ACS Central Science. 5, 1315-1329.

Identification

■ Electron ■ Neutron ■ X-ray

There are a number of automatic processes used during CCDC's Data Curation process to identify nonroutine structures. These heavily rely on the information in the deposited CIF files. An assessment of electron diffraction data found 61% of data could be identified by the curation process, while other structures were identified after curation from other places in the CIF which are not checked by the curation software. A very small number of structures did not contain identifying information in the CIFs at all.

The CCDC has created an FAQ about electron diffraction data in the CSD, which provides the definition of suggested information to include in a CIF.

Informatio	on to	includ

_diffrn_radiation_probe 'electron'

CIF field

Future Developments

Although the current number of electron diffraction datasets in the CSD is small, it is important that they are properly curated so they are findable and useful to users. We would like to hear your input on any ways we can support the growth of this technique.

Identification method	% of CIFs
Automatic from CIF	61 %
Wavelength*	25 %
Information provided elsewhere	13 %
Only identifiable from paper	1%

* Electron radiation wavelength is typically 0.02-0.03 Å

The method used to measure the data e.g. 'Rotation Electron Diffraction'	
'electron'	
The general electron source used in experiment e.g. 'electron microscope'	
Specific information about the electron source used, such as make/model or name of the equipment	
The general name of the equipment used to collect the diffraction data	
Specific make/model of the equipment used e.g. 'FEI Tecnai F30ST'	
The general name of the detector used	
Specific make/model of the detector used	
Any additional special details about the experimental setup	
Any additional special details about the diffraction data collection	

The CCDC is also planning other improvement work, for instance the standardisation of property fields such as melting point data and undertaking an analysis of polymorphic data in the CSD to see how this information could be enhanced to increase consistency.

We would also like to hear your input of what future projects that CCDC should undertake to help users to get the most out of the CSD. Please share your thoughts to hello@ccdc.cam.ac.uk.

www.ccdc.cam.ac.uk

Colin R. Groom, et al., The Cambridge Structural Database, Acta Cryst. B, 2016, **72**, 171, DOI: 10.1107/S2052520616003954

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